

## Magnetic compensations in $\text{Mn}_{4-x}\text{Co}_x\text{N}$ epitaxial films proved by X-ray magnetic circular dichroism

H. Mitarai<sup>1</sup>, T. Komori<sup>1</sup>, T. Hirose<sup>1</sup>, K. Ito<sup>2,3</sup>, K. Toko<sup>1</sup>, K. Amemiya<sup>4</sup>, and T. Suemasu<sup>1</sup>

1. Inst. of Appl. Phys., Univ. of Tsukuba 2. IMR, Tohoku Univ. 3. CSRN, Tohoku Univ.

4. IMSS, KEK

E-mail: s2020296@u.tsukuba.ac.jp

### [Introduction]

$\text{Mn}_4\text{N}$  film is an antiperovskite ferrimagnet without rare-earth which is advantageous in fast magnetization reversal due to its perpendicular magnetic anisotropy ( $K_u \sim 1.1 \times 10^5 \text{ J/m}^3$ ) and a small saturation magnetization ( $M_S = 71 \text{ kA/m}$ )<sup>[1]</sup>. Previous study on 1–2  $\mu\text{m}$ -wide  $\text{Mn}_4\text{N}$  strips showed the fastest spin-transfer-torque-driven domain wall motion ( $v_{\text{DW}} \approx 900 \text{ m/s}$  at  $1.3 \times 10^{12} \text{ A/m}^2$ ) at room temperature (RT)<sup>[1]</sup>. To achieve faster  $v_{\text{DW}}$ ,  $\text{Mn}_4\text{N}$  based mixed crystals have been studied in pursuit of compensation. Recently,  $\text{Mn}_{4-x}\text{Ni}_x\text{N}$  films have been suggested to have a magnetic compensation (MC) point between  $x = 0.1$  and  $0.25$  at RT<sup>[2]</sup>. We found that  $\text{Mn}_{4-x}\text{Co}_x\text{N}$  films have a compensation point between  $x = 0$  and  $0.8$  from the result of x-ray magnetic circular dichroism (XMCD) measurements<sup>[3]</sup>. However, there is a lack of information about the magnetic behavior of  $\text{Mn}_{4-x}\text{Co}_x\text{N}$  at values  $x$  much smaller or larger than  $0.8$ . In this work, we performed XMCD measurements on  $\text{Mn}_{4-x}\text{Co}_x\text{N}$  epitaxial films at  $x = 0.2$  and  $1.3$  and investigated the change in magnetic structures by composition ratio to verify MC at RT in this material.

### [Experiment]

20–30 nm-thick  $\text{Mn}_{4-x}\text{Co}_x\text{N}$  films with  $x = 0-1.3$

were epitaxially grown on  $\text{SrTiO}_3(001)$  substrates by molecular beam epitaxy.  $\text{SiO}_2$  or Ta capping layers were sputtered *in-situ* on the surface to prevent oxidation. X-ray absorption spectroscopy (XAS) and XMCD measurements were performed at BL-16A of Photon Factory.

### [Result and discussion]

Figures 1(a)-1(c) show the XAS and XMCD spectra of Mn in  $\text{Mn}_{4-x}\text{Co}_x\text{N}$  at  $x = 0.2, 0.8$ <sup>[3]</sup>, and  $1.3$ , respectively. In these figures, the sharp peak near  $640 \text{ eV}$  comes from Mn atoms at corner sites, and the broad peak near  $643 \text{ eV}$  originates from those at face-centered sites<sup>[3]</sup>. We observed the sign reversals of XMCD signals between  $x = 0.2$  and  $0.8$ , and also between  $x = 0.8$  and  $1.3$ . Similar sign reversals were also observed in the XMCD signals of Co atoms. These results indicate that MC occurs twice in the range of  $x = 0-1.3$  in  $\text{Mn}_{4-x}\text{Co}_x\text{N}$ .

### Acknowledgment

The XMCD experiment was performed with the approval of the Photon Factory Program Advisory Committee (Proposal No. 2019G574).

### [References]

- [1] T. Gushi *et al.*, Nano Lett., **19**, 8716 (2019).
- [2] T. Komori *et al.*, JAP, **127**, 043903 (2020).
- [3] K. Ito *et al.*, Phys. Rev. B **101**, 104401 (2020).

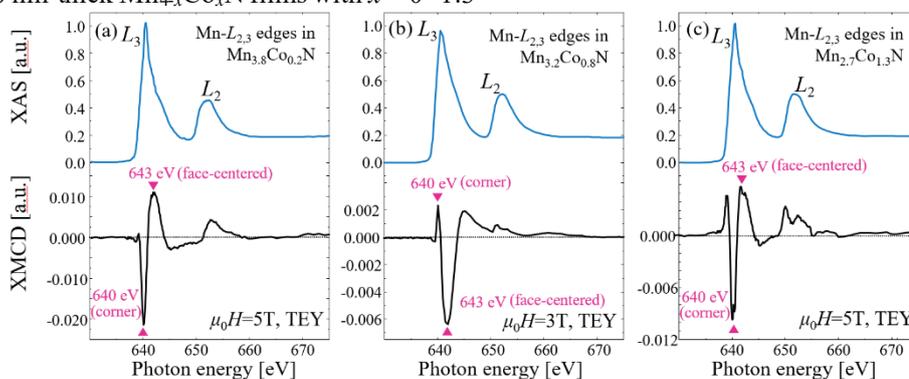


Fig. 1 XAS (blue) and XMCD (black) spectra in (a)  $\text{Mn}_{3.8}\text{Co}_{0.2}\text{N}$ , (b)  $\text{Mn}_{3.2}\text{Co}_{0.8}\text{N}$ <sup>[3]</sup>, and (c)  $\text{Mn}_{2.7}\text{Co}_{1.3}\text{N}$  films at the Mn  $L_{2,3}$  absorption edges.